Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/520,427	MIYAUCHI, TSUTOMU
Examiner	Art Unit
Than Nguyen	2187

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST Inventor IEEE	1/3/2007	NTV		
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